Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,462	CHEN ET AL.
Examiner	Art Unit
Juan A. Torres	2611

SEARCHED				
Class	Subclass	Date	Examiner	
updated	魯	5/24/2007	JATM	
3×5	348	777	2)	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	233	5/24/2007	JATM	
			<u> </u>	

SEARCH (INCLUDING SEAR)
	DATE	EXMR
EAST	5/24/2007	JATM
IDS Flag clearance	5/24/2007	JATM
Inventor search	5/24/2007	· JATM
Claim interference search	5/24/2007	JATM
Google	5/24/2007	JATM
Sciris	5/24/2007	JATM
IEEE	5/24/2007	JATM